



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

DMG6602SVT

Product Summary

Device	V _{(BR)DSS}	R _{DS(on)}	Ι _D Τ _A = 25°C
Q1	30V	$60m\Omega @ V_{GS} = 10V$	3.4A
QT		100m Ω @ V _{GS} = 4.5V	2.7A
02	2014	95mΩ @ V_{GS} = -10V	-2.8A
Q2	-30V	140m Ω @ V _{GS} = -4.5V	-2.3A

Description and Applications

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- DC-DC Converters
- Power management functions

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free Finish; RoHS compliant (Note 1)
- Halogen and Antimony Free. "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

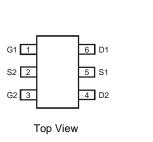
Mechanical Data

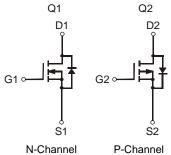
- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.013 grams (approximate)



TSOT26

Top View





Ordering Information (Note 3)

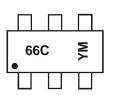
Part Number	Case	Packaging
DMG6602SVT-7	TSOT26	3000 / Tape & Reel

Notes: 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.

2. Halogen and Antimony free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

3. For packaging details, go to our website at http://www.diodes.com.

Marking Information



66C = Product Type Marking Code YM = Date Code Marking Y = Year (ex: X = 2010) M = Month (ex: 9 = September)

Date Code Key												
Year	2010		2011	2012		2013	2014		2015	2016		2017
Code	Х		Y	Z		А	В		С	D		E
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings – Q1 @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage			V _{DSS}	30	V
Gate-Source Voltage	V _{GSS}	±20	V		
Continuous Drain Current (Note 5) V_{GS} = 10V	Steady State	T _A = 25°C T _A = 70°C	I _D	3.4 2.7	А
Continuous Drain Current (Note 5) V_{GS} = 4.5V	I _D	2.7 2.2	A		
Maximum Continuous Body Diode Forward Current (I	ls	1.5	A		
Pulsed Drain Current (Note 5)			I _{DM}	25	A

Maximum Ratings - Q2 @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage			V _{DSS}	-30	V
Gate-Source Voltage	V _{GSS}	±20	V		
Continuous Drain Current (Note 5) V_{GS} = -10V	Steady State	T _A = 25°C T _A = 70°C	I _D	-2.8 -2.4	А
Continuous Drain Current (Note 5) V_{GS} = -4.5V	I _D	-2.3 -2.1	А		
Maximum Continuous Body Diode Forward Current (ls	-1.5	A		
Pulsed Drain Current (Note 5)	I _D	-20	A		

Thermal Characteristics

Characteristic		Symbol	Value	Units	
Total Dowar Dissinction (Note 4)	$T_A = 25^{\circ}C$	D	0.84	W	
Total Power Dissipation (Note 4)	T _A = 70°C	PD	0.52		
Thermal Resistance, Junction to Ambient (Note 4)	Steady state	D	155	°C/W	
mermai Resistance, Junction to Ambient (Note 4)	t<10s	$R_{ extsf{ heta}JA}$	109		
Total Dower Discipation (Note 5)	$T_A = 25^{\circ}C$	Р	1.27	W	
Total Power Dissipation (Note 5)	T _A = 70°C	PD	0.8	vv	
Thermal Registeres, Junction to Ambient (Note 5)	Steady state	D	102		
Thermal Resistance, Junction to Ambient (Note 5) t<10s		$R_{ extsf{ heta}JA}$	71	°C/W	
Thermal Resistance, Junction to Case (Note 5)		R _θ JC	34		
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C	

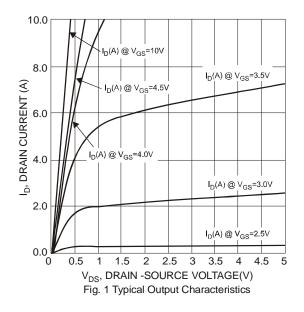
Notes:4. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

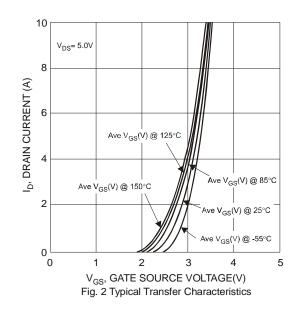


Electrical Characteristics – Q1 NMOS @ TA = 25°C unless otherwise stated

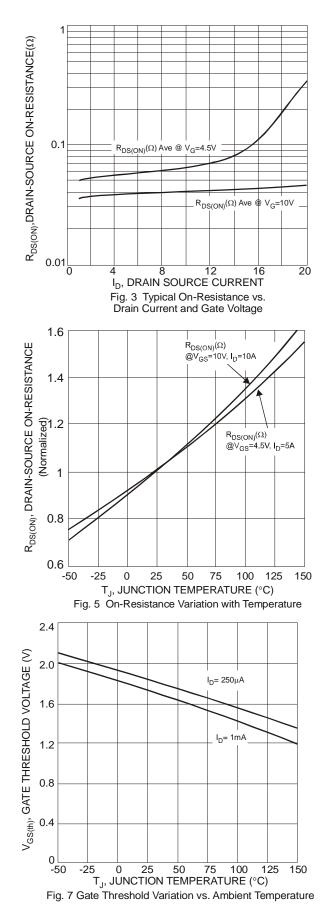
Oberestaristic	Cumula al	Min	True	Max	11	Toot Condition
	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)			i	r		
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	$V_{GS} = 0V, I_D = 250 \mu A$
Zero Gate Voltage Drain Current	I _{DSS}	-	-	1.0	μA	$V_{DS} = 24V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V _{GS(th)}	1.0	-	2.3	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Static Drain-Source On-Resistance	D		38	60	mΩ	$V_{GS} = 10V, I_D = 3.1A$
Static Drain-Source On-Resistance	R _{DS (ON)}	-	55	100	11122	$V_{GS} = 4.5V, I_D = 2A$
Forward Transfer Admittance	Y _{fs}	-	4	-	S	$V_{DS} = 5V, I_D = 3.1A$
Diode Forward Voltage	V _{SD}	-	0.8	1	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 7)						_
Input Capacitance	C _{iss}	-	290	400		$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.2MHz
Output Capacitance	Coss	-	40	80	pF	
Reverse Transfer Capacitance	C _{rss}	-	40	80		
Gate Resistance	Rg	-	1.4	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge ($V_{GS} = 4.5V$)	Qg	-	4	6		$V_{DS} = 15V, V_{GS} = 4.5V, I_D = 3.1A$
Total Gate Charge (V _{GS} = 10V)	Qg	-	9	13	-0	
Gate-Source Charge	Q _{gs}	-	1.2	-	nC	$V_{DS} = 15V, V_{GS} = 10V, I_D = 3A$
Gate-Drain Charge	Q _{gd}	-	1.5	-		
Turn-On Delay Time	t _{D(on)}	-	3	-		
Turn-On Rise Time	tr	-	5	-		V _{GS} = 10V, V _{DS} = 15V,
Turn-Off Delay Time	t _{D(off)}	-	13	-	ns	$R_G = 3\Omega, R_L = 4.7\Omega$
Turn-Off Fall Time	tf	-	3	-		

Notes:6. Short duration pulse test used to minimize self-heating effect.7. Guaranteed by design. Not subject to product testing.









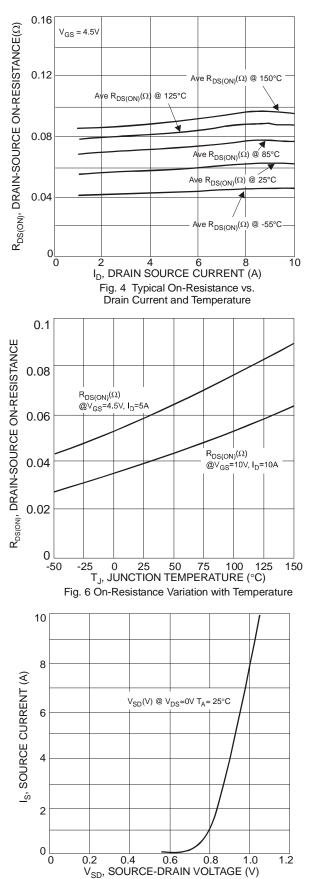
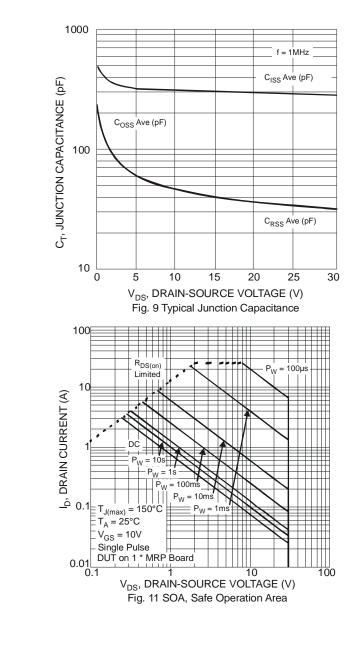
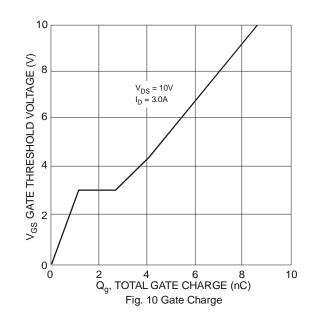


Fig. 8 Diode Forward Voltage vs. Current



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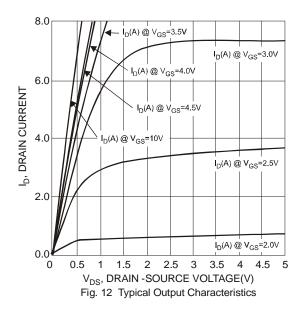


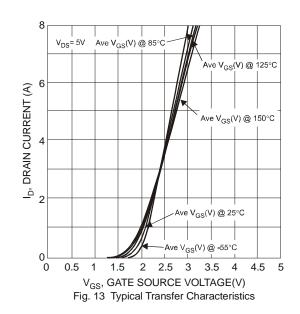
Electrical Characteristics – Q2 PMOS@ T_A = 25°C unless otherwise stated

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)	<u>.</u>					
Drain-Source Breakdown Voltage	BV _{DSS}	-30	-	-	V	$V_{GS} = 0V, I_D = -250 \mu A$
Zero Gate Voltage Drain Current	IDSS	-	-	-1.0	μA	$V_{DS} = -24V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V _{GS(th)}	-1.0	-	-2.3	V	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$
Static Drain-Source On-Resistance	Deserver		73	95	mΩ	$V_{GS} = -10V, I_D = -2.7A$
Static Drain-Source On-Resistance	R _{DS} (ON)	-	99	140	11152	$V_{GS} = -4.5V, I_D = -2A$
Forward Transfer Admittance	Y _{fs}	-	6	-	S	$V_{DS} = -5V, I_D = -2.7A$
Diode Forward Voltage	V _{SD}	-	-0.8	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	Ciss	-	350	420		
Output Capacitance	Coss	-	50	100	pF	V _{DS} = -15V, V _{GS} = 0V, f = 1.2MHz
Reverse Transfer Capacitance	C _{rss}	-	45	80		1 = 1.210112
Gate Resistance	Rg	-	17.1	-	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$
Total Gate Charge (V _{GS} = -4.5V)	Qg	-	4	6		$V_{DS} = -15V, V_{GS} = -4.5V, I_{D} = -3A$
Total Gate Charge (V _{GS} = -10V)	Qg	-	7	9	-0	
Gate-Source Charge	Q _{gs}	-	0.9	-	nC	V _{DS} = -15V, V _{GS} = -10V, I _D = -3A
Gate-Drain Charge	Q _{gd}	-	1.2	-		
Turn-On Delay Time	t _{D(on)}	-	4.8	-		
Turn-On Rise Time	tr	-	7.3	-		V _{GS} = -10V, V _{DS} = -15V,
Turn-Off Delay Time	t _{D(off)}	-	20	-	ns	$R_G = 6\Omega, R_L = 15\Omega$
Turn-Off Fall Time	t _f	-	13	-		

 Notes:
 6. Short duration pulse test used to minimize self-heating effect.

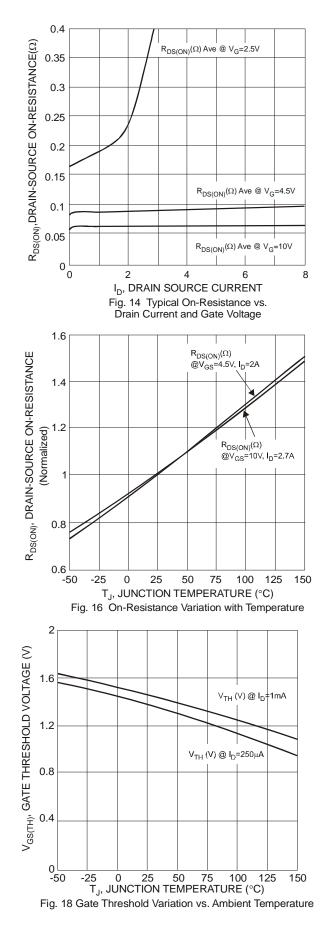
 7. Guaranteed by design. Not subject to production testing.

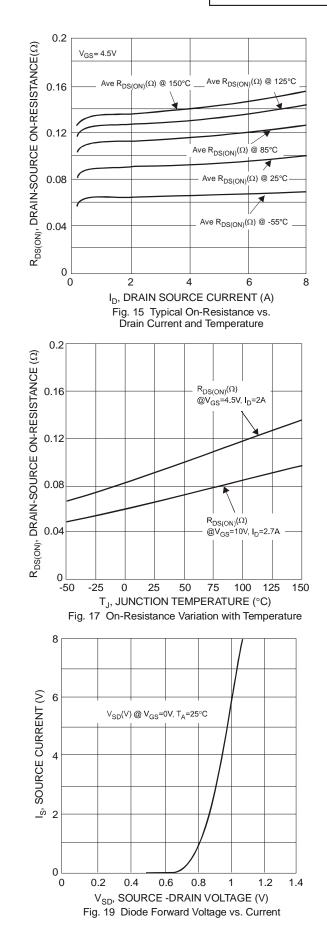






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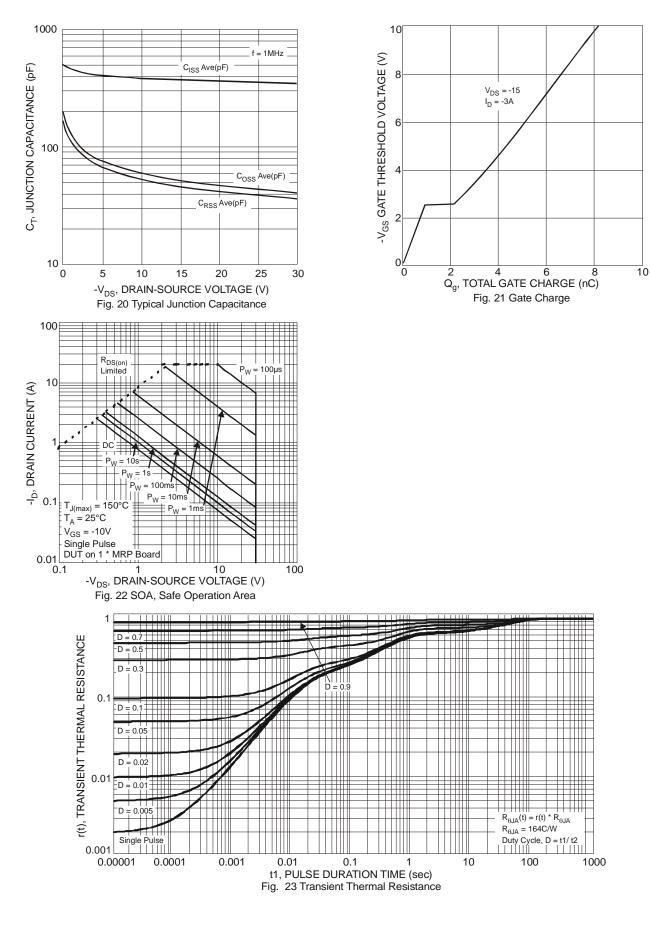




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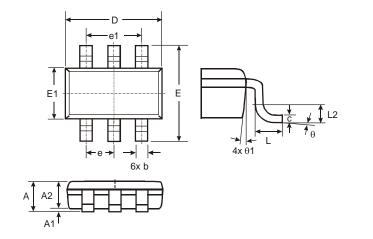


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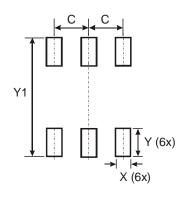


Package Outline Dimensions



	TSO	T26	
Dim	Min	Max	Тур
Α	_	1.00	-
A1	0.01	0.10	-
A2	0.84	0.90	-
D	-	-	2.90
Е	_	_	2.80
E1	_	-	1.60
b	0.30	0.45	-
с	0.12	0.20	-
e	-	-	0.95
e1	_		1.90
L	0.30	0.50	
L2	_	-	0.25
θ	0°	8°	4°
θ1	4°	12°	_
All D	imensi	ons in	mm

Suggested Pad Layout



Dimensions	Value (in mm)
С	0.950
Х	0.700
Y	1.000
Y1	3.199



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